

CE EMC TEST REPORT

Report No.: DDT-B23082413-1E01

Applicant	:	TPV Electronics (Fujian) Co., Ltd.
Address	:	Rongqiao Economic and Technological Development Zone, Fuqing City, Fujian Province, P.R. China
Equipment under Test	:	LCD Monitor
Model No.	:	**24G4***** ("*" = 0-9, A-Z, a-z, +, -, /, \ or blank)
Trade Mark	:	AOC

Issued By: Tianjin Dongdian Testing Service Co., Ltd.

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CONTENTS

1.	Summary of Test Results	6
2.	General Test Information	7
2.1	Description of EUT	7
2.2	Primary Function of EUT	7
2.3	Port of EUT	7
2.4	Accessories of EUT	8
2.5	Test peripherals	8
2.6	Block diagram EUT configuration for test	9
2.7	EUT operating mode(s)	9
2.8	Performance Criteria	9
2.9	Deviations of test standard	10
2.10	Test laboratory	10
2.11	Measurement uncertainty	10
2.12	Abbreviations	11
3	Conducted Emissions (AC mains power ports)	12
3.1	General Information	12
3.2	Test Equipment	12
3.3	Reference Standard	12
3.4	Test Arrangement	12
3.5	Test Specification and Limit	13
3.6	Test Result	14
4	Radiated Emissions (30MHz to 1GHz)	16
4.1	General Information	16
4.2	Test Equipment	16
4.3	Reference Standard	16
4.4	Test Arrangement	17
4.5	Test Specification and Limit	18
4.6	Test Result	19
5	Radiated Emissions (Above 1GHz)	21
5.1	General Information	21
5.2	Test Equipment	21
5.3	Reference Standard	21
5.4	Test Arrangement	21
5.5	Test Specification and Limit	23
5.6	Test Result	23
6	Harmonic Current Emissions	25
6.1	General Information	25
6.2	Test Equipment	25
6.3	Reference Standard	25
6.4	Test Arrangement	25
6.5	Test Specification and Limit	26
6.6	Test Result	26
7	Voltage Changes, Voltage Fluctuations and Flicker	27
7.1	General Information	27
7.2	Test Equipment	27
7.3	Reference Standard	27
7.4	Test Arrangement	27
7.5	Test Specification and Limit	27
7.6	Test Result	28
8	Electrostatic Discharge Immunity	29
8.1	General Information	29
8.2	Test Equipment	29
8.3	Reference Standard	29
8.4	Test Arrangement	29
8.5	Test Specification and Limit	30
8.6	Test Result	30
9	Radiated, Radio-frequency, Electromagnetic Field Immunity	32

9.1	General Information	32
9.2	Test Equipment.....	32
9.3	Reference Standard.....	32
9.4	Test Arrangement	33
9.5	Test Specification and Limit.....	33
9.6	Test Result.....	34
10	Electrical Fast Transient/Burst Immunity	35
10.1	General Information	35
10.2	Test Equipment.....	35
10.3	Reference Standard.....	35
10.4	Test Arrangement	35
10.5	Test Specification and Limit.....	36
10.6	Test Result.....	37
11	Surge Immunity.....	38
11.1	General Information	38
11.2	Test Equipment.....	38
11.3	Reference Standard.....	38
11.4	Test Arrangement	38
11.5	Test Specification and Limit.....	39
11.6	Test Result.....	40
12	Immunity to Conducted Disturbances, Induced by Radio-frequency Fields	41
12.1	General Information	41
12.2	Test Equipment.....	41
12.3	Reference Standard.....	41
12.4	Test Arrangement	42
12.5	Test Specification and Limit.....	43
12.6	Test Result.....	43
13	Power Frequency Magnetic Field Immunity	44
13.1	General Information	44
13.2	Test Equipment.....	44
13.3	Reference Standard.....	44
13.4	Test Arrangement	45
13.5	Test Specification and Limit.....	45
13.6	Test Result.....	45
14	Voltage Dips, Short Interruptions and Voltage Variations Immunity	46
14.1	General Information	46
14.2	Test Equipment.....	46
14.3	Reference Standard.....	46
14.4	Test Arrangement	46
14.5	Test Specification and Limit.....	47
14.6	Test Result.....	47
	Annex A.Test Setup Photos	48
A.1	Conducted Emissions (AC mains power ports).....	48
A.2	Radiated Emissions (30MHz to 1GHz).....	49
A.3	Radiated Emissions (Above 1GHz).....	50
A.4	Harmonic Current Emissions	51
A.5	Voltage Changes, Voltage Fluctuations and Flicker	51
A.6	Electrostatic Discharge Immunity	52
A.7	Radiated, Radio-frequency, Electromagnetic Field Immunity	52
A.8	Electrical Fast Transient/Burst Immunity	53
A.9	Surge Immunity.....	54
A.10	Immunity to Conducted Disturbances, Induced by Radio-frequency Fields	54
A.11	Power Frequency Magnetic Field Immunity	55
A.12	Voltage Dips, Short Interruptions and Voltage Variations Immunity	55

Test Report Declare

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Test Standard Used:

AS/NZS CISPR 32:2015 AMD 1:2020,BS EN 55032:2015,BS EN 55032:2015+A11:2020,
BS EN 55032:2015+A1:2020,BS EN 55035:2017,BS EN 55035:2017+A11:2020,
BS EN 61000-3-2:2014,BS EN 61000-3-3:2013,BS EN 61000-3-3:2013+A1:2019,
BS EN 61000-3-3:2013+A2:2021,BS EN IEC 61000-3-2:2019+A1:2021,
CISPR 32:2015/AMD1:2019,CISPR 35:2016,EN 55032:2015,EN 55032:2015/A11:2020,
EN 55032:2015/A1:2020,EN 55035:2017,EN 55035:2017/A11:2020,
EN 61000-3-2:2014,EN 61000-3-3:2013,EN 61000-3-3:2013/A1:2019,
EN 61000-3-3:2013/A2:2021,EN IEC 61000-3-2:2019/A1:2021,IEC 61000-4-11:2020,
IEC 61000-4-2:2008,IEC 61000-4-3:2020,IEC 61000-4-4:2012,IEC 61000-4-5:2014/AMD1:2017,
IEC 61000-4-6:2013,IEC 61000-4-8:2009

We Declare:

The equipment described above is tested and assessed by Tianjin Dongdian Testing Service Co., Ltd. and in the configuration assessed the equipment complied with the standards specified above. The tested and assessed results are contained in this test report and Tianjin Dongdian Testing Service Co., Ltd. is assumed of full responsibility for the accuracy and completeness of these assessments.

After test and evaluation, our opinion is that the equipment provided for test compliance with the requirement of the above standards.

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Revision History

Rev.	Revisions	Issue Date	Revised By
---	Initial issue	Sep. 11, 2023	